AD827* PRODUCT PAGE QUICK LINKS

Last Content Update: 10/20/2017

COMPARABLE PARTS 🖵

View a parametric search of comparable parts.

DOCUMENTATION

Application Notes

- AN-402: Replacing Output Clamping Op Amps with Input Clamping Amps
- AN-417: Fast Rail-to-Rail Operational Amplifiers Ease Design Constraints in Low Voltage High Speed Systems
- AN-581: Biasing and Decoupling Op Amps in Single **Supply Applications**

Data Sheet

- AD827: High Speed, Low Power Dual Op Amp Data Sheet
- AD827: Military Data Sheet

TOOLS AND SIMULATIONS .

- · Analog Photodiode Wizard

· Analog Filter Wizard

- · Power Dissipation vs Die Temp
- VRMS/dBm/dBu/dBV calculators
- AD827 SPICE Macro Model

REFERENCE MATERIALS 🖳

Product Selection Guide

High Speed Amplifiers Selection Table

Tutorials

- MT-032: Ideal Voltage Feedback (VFB) Op Amp
- MT-047: Op Amp Noise
- MT-048: Op Amp Noise Relationships: 1/f Noise, RMS Noise, and Equivalent Noise Bandwidth
- MT-049: Op Amp Total Output Noise Calculations for Single-Pole System
- MT-050: Op Amp Total Output Noise Calculations for Second-Order System
- MT-052: Op Amp Noise Figure: Don't Be Misled
- MT-053: Op Amp Distortion: HD, THD, THD + N, IMD, SFDR, MTPR
- MT-056: High Speed Voltage Feedback Op Amps
- MT-058: Effects of Feedback Capacitance on VFB and CFB Op Amps
- · MT-060: Choosing Between Voltage Feedback and Current Feedback Op Amps

DESIGN RESOURCES \Box

- · AD827 Material Declaration
- PCN-PDN Information
- · Quality And Reliability
- · Symbols and Footprints

DISCUSSIONS

View all AD827 EngineerZone Discussions.

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Submit a technical question or find your regional support number.

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AD827—SPECIFICATIONS (@ $T_A = +25$ °C, unless otherwise noted.)

			AD827J			AD827A/S			
Model	Conditions	V_{S}	Min	Typ	Max	Min	Typ	Max	Unit
DC PERFORMANCE Input Offset Voltage ¹	T_{MIN} to T_{MAX}	±5 V		0.5	2 3.5		0.3	2 4	mV mV
Offset Voltage Drift Input Bias Current Input Offset Current Offset Current Drift Common-Mode Rejection Ratio Power Supply Rejection Ratio Open-Loop Gain	T_{MIN} to T_{MAX} T_{MIN} to T_{MAX} T_{MIN} to T_{MAX} $V_{CM} = \pm 2.5 \text{ V}$ $V_{CM} = \pm 12 \text{ V}$ T_{MIN} to T_{MAX} T_{MIN} to T_{MAX} $V_{O} = \pm 2.5 \text{ V}$	±15 V ±5 V to ±15 V ±5 V to ±15 V ±5 V to ±15 V ±5 V to ±15 V ±5 V ±15 V ±5 V to ±15 V ±5 V to ±15 V ±5 V to ±15 V	78 78 75 75 72	15 3.3 50 0.5 95 95	4 6 7 8.2 300 400	80 80 75 75 72	15 3.3 50 0.5 95 95 86	4 6 7 9.5 300 400	mV mV μV/°C μA μA nA nA/°C dB dB dB dB dB
	$R_{LOAD} = 500 \ \Omega$ $T_{MIN} \text{ to } T_{MAX}$ $R_{LOAD} = 150 \ \Omega$ $V_{OUT} = \pm 10 \ V$ $R_{LOAD} = 1 \ k\Omega$ $T_{MIN} \text{ to } T_{MAX}$	±15 V	2 1 3 1.5	3.51.65.5		2 1 3 1.5	3.51.65.5		V/mV V/mV V/mV V/mV
MATCHING CHARACTERISTICS Input Offset Voltage Crosstalk	f = 5 MHz	±5 V ±5 V		0.4 85			0.2 85		mV dB
DYNAMIC PERFORMANCE Unity-Gain Bandwidth		±5 V ±15 V		35 50			35 50		MHz MHz
Full Power Bandwidth ²	$V_{O} = 5 \text{ V p-p},$ $R_{LOAD} = 500 \Omega$ $V_{O} = 20 \text{ V p-p},$ $R_{LOAD} = 1 \text{ k}\Omega$	±5 V ±15 V		12.7 4.7			12.7 4.7		MHz MHz
Slew Rate ³	$R_{LOAD} = 500 \Omega$ $R_{LOAD} = 1 k\Omega$	±5 V ±15 V		200 300			200 300		V/µs V/µs
Settling Time to 0.1%	$A_V = -1$ -2.5 V to +2.5 V -5 V to +5 V	±5 V ±15 V		65 120			65 120		ns ns
Phase Margin Differential Gain Error Differential Phase Error Input Voltage Noise Input Current Noise Input Common-Mode Voltage Range	$\begin{split} C_{LOAD} &= 10 \text{ pF} \\ R_{LOAD} &= 1 \text{ k}\Omega \\ f &= 4.4 \text{ MHz} \\ f &= 4.4 \text{ MHz} \\ f &= 10 \text{ kHz} \\ f &= 10 \text{ kHz} \end{split}$	±15 V ±15 V ±15 V ±15 V ±15 V ±5 V		50 0.04 0.19 15 1.5 +4.3 -3.4			50 0.04 0.19 15 1.5 +4.3 -3.4		Degrees % Degrees nV/√Hz pA/√Hz V V
Output Voltage Swing Short-Circuit Current Limit	$R_{LOAD} = 500 \Omega$ $R_{LOAD} = 150 \Omega$ $R_{LOAD} = 1 k\Omega$ $R_{LOAD} = 500 \Omega$	±15 V ±5 V ±5 V ±15 V ±15 V ±5 V to ±15 V	3.0 2.5 12 10	-3.4 +14.3 -13.4 3.6 3.0 13.3 12.2 32		3.0 2.5 12 10	-3.4 +14.3 -13.4 3.6 3.0 13.3 12.2 32		V V V ±V ±V ±V ±V mA
INPUT CHARACTERISTICS Input Resistance Input Capacitance				300 1.5			300 1.5		kΩ pF

				AD827]	J		AD827	'A/S	
Model	Conditions	$\mathbf{v_s}$	Min	Typ	Max	Min	Typ	Max	Unit
OUTPUT RESISTANCE	Open Loop			15				15	Ω
POWER SUPPLY Operating Range Quiescent Current	${ m T_{MIN}}$ to ${ m T_{MAX}}$	±5 V ±15 V	±4.5	10 10.5	±18 13 16 13.5 16.5	±4.5	10 10.5	±18 13 16.5/17.5 13.5 17/18	V mA mA mA
TRANSISTOR COUNT				92			92		

NOTES

All min and max specifications are guaranteed.

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS1

NOTES

Thermal Characteristics:

MiniDIP: $\theta_{JA} = 100^{\circ}\text{C/W}$; $\theta_{JC} = 33^{\circ}\text{C/W}$

Cerdip: $\theta_{JA} = 110^{\circ}\text{C/W}; \ \theta_{JC} = 30^{\circ}\text{C/W}$ 16-Lead Small Outline Package: $\theta_{JA} = 100^{\circ}\text{C/W}$

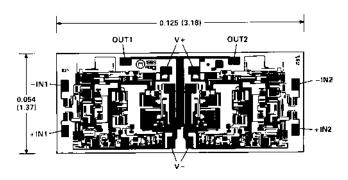
20-Lead LCC: $\theta_{IA} = 150^{\circ}\text{C/W}$; $\theta_{IC} = 35^{\circ}\text{C/W}$

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option	
AD827JN	0°C to +70°C	8-Lead Plastic DIP	N-8	
AD827JR	0°C to +70°C	16-Lead Plastic SO	R-16	
AD827AQ	–40°C to +85°C	8-Lead Cerdip	Q-8	
AD827SQ	−55°C to +125°C	8-Lead Cerdip	Q-8	
AD827SQ/883B	−55°C to +125°C	8-Lead Cerdip	Q-8	
5962-9211701MPA	−55°C to +125°C	8-Lead Cerdip	Q-8	
AD827SE/883B	−55°C to +125°C	20-Lead LCC	E-20A	
5962-9211701M2A	−55°C to +125°C	20-Lead LCC	E-20A	
AD827JR-REEL	0°C to +70°C	Tape & Reel		
AD827JChips	0°C to +70°C	Die		
AD827SChips	−55°C to +125°C	Die		

METALLIZATION PHOTOGRAPH

Contact factory for latest dimensions. Dimensions shown in inches and (mm). Substrate is connected to V+.



REV. C -3-

¹ Offset voltage for the AD827 is guaranteed after power is applied and the device is fully warmed up. All other specifications are measured using high speed test equipment, approximately 1 second after power is applied.

 $^{^{2}}$ Full Power Bandwidth = Slew Rate/2 π V_{PEAK}.

³ Gain = +1, rising edge.

¹ Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

 $^{^2}$ Maximum internal power dissipation is specified so that T_J does not exceed 175 $^{\circ}\text{C}$ at an ambient temperature of 25°C.

³ Indefinite short circuit duration is only permissible as long as the absolute maximum power rating is not exceeded.

AD827—Typical Performance Characteristics (@ +25°C & ±15 V, unless otherwise noted)

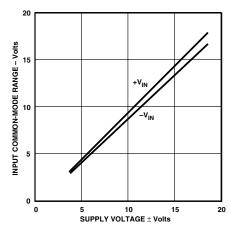


Figure 1. Input Common-Mode Range vs. Supply Voltage

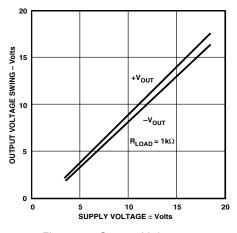


Figure 2. Output Voltage Swing vs. Supply Voltage

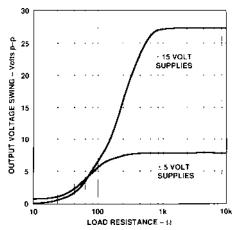


Figure 3. Output Voltage Swing vs. Load Resistance

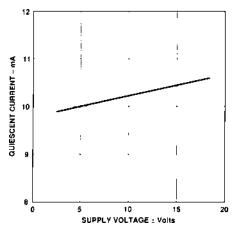


Figure 4. Quiescent Current vs. Supply Voltage

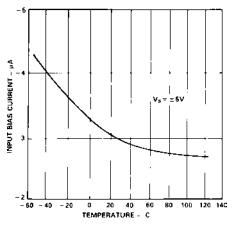


Figure 5. Input Bias Current vs. Temperature

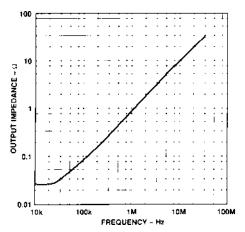


Figure 6. Closed-Loop Output Impedance vs. Frequency, Gain = +1

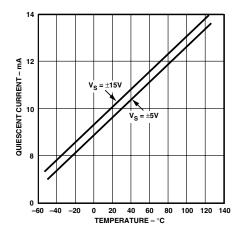


Figure 7. Quiescent Current vs. Temperature

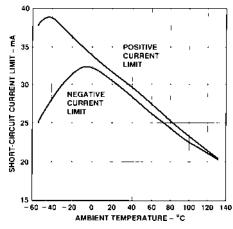


Figure 8. Short-Circuit Current Limit vs. Temperature

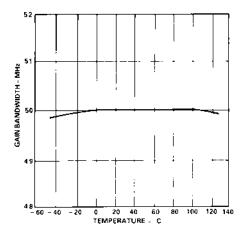
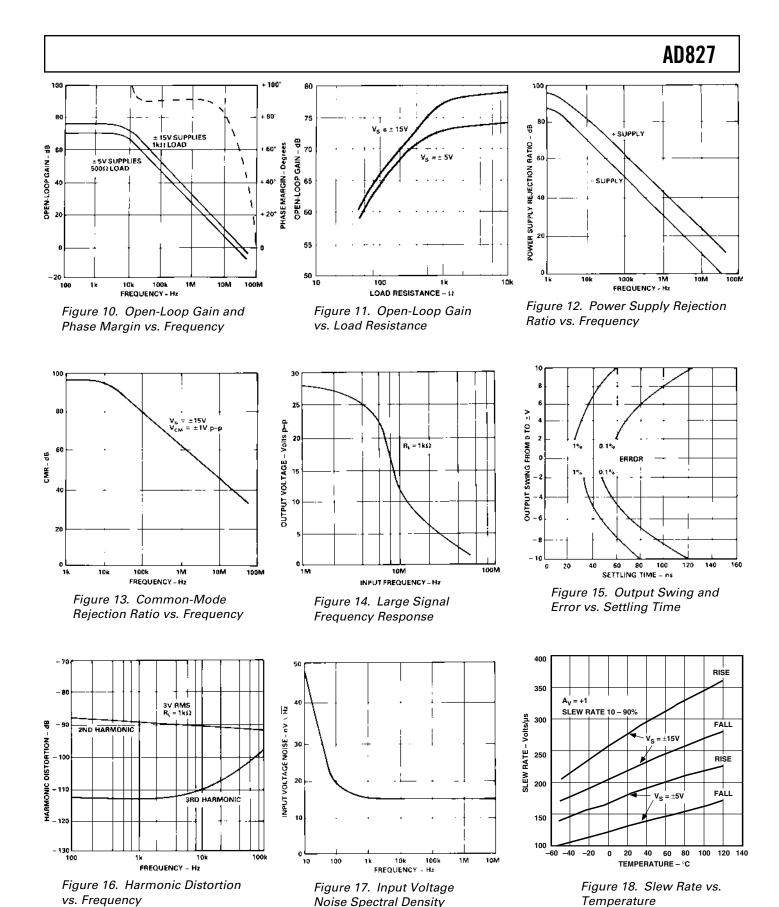


Figure 9. Gain Bandwidth vs. Temperature



Noise Spectral Density

REV. C -5-

AD827

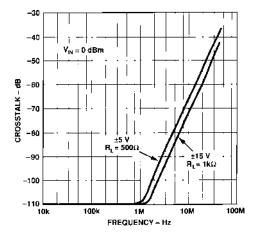


Figure 19. Crosstalk vs. Frequency

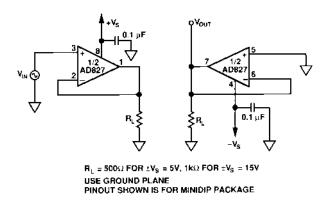


Figure 20. Crosstalk Test Circuit

INPUT PROTECTION PRECAUTIONS

An input resistor (resistor $R_{\rm IN}$ of Figure 21a) is recommended in circuits where the input common-mode voltage to the AD827 may exceed (on a transient basis) the positive supply voltage. This resistor provides protection for the input transistors by limiting the maximum current that can be forced into their bases.

For high performance circuits, it is recommended that a second resistor (R_B in Figures 21a and 22a) be used to reduce biascurrent errors by matching the impedance at each input. This resistor reduces the error caused by offset voltages by more than an order of magnitude.

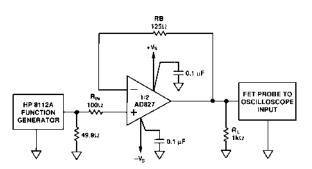


Figure 21a. Follower Connection

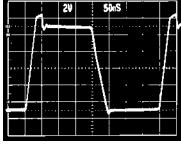


Figure 21b. Follower Large Signal Pulse Response

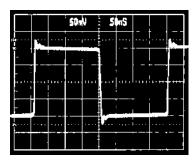


Figure 21c. Follower Small Signal Pulse Response

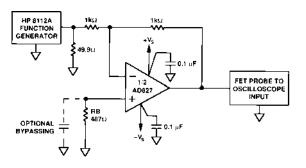


Figure 22a. Inverter Connection

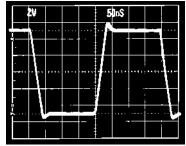


Figure 22b. Inverter Large Signal Pulse Response

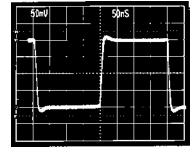


Figure 22c. Inverter Small Signal Pulse Response

VIDEO LINE DRIVER

The AD827 functions very well as a low cost, high speed line driver for either terminated or unterminated cables. Figure 23 shows the AD827 driving a doubly terminated cable in a follower configuration.

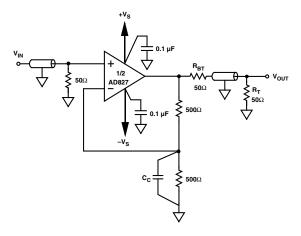


Figure 23. A Video Line Driver

The termination resistor, R_T , (when equal to the cable's characteristic impedance) minimizes reflections from the far end of the cable. While operating from ± 5 V supplies, the AD827 maintains a typical slew rate of 200 V/µs, which means it can drive a ± 1 V, 30 MHz signal into a terminated cable.

Table I. Video Line Driver Performance Summary

V _{IN} *	V _{SUPPLY}	C _C	-3 dB B _W	Over- shoot
0 dB or ±500 mV Step	±15	20 pF	23 MHz	4%
0 dB or ±500 mV Step	±15	15 pF	21 MHz	0%
0 dB or ±500 mV Step	±15	0 pF	13 MHz	0%
0 dB or ±500 mV Step	±5	20 pF	18 MHz	2%
0 dB or ±500 mV Step	±5	15 pF	16 MHz	0%
0 dB or ±500 mV Step	±5	0 pF	11 MHz	0%

^{*-3} dB bandwidth numbers are for the 0 dBm signal input. Overshoot numbers are the percent overshoot of the 1 V step input.

A back-termination resistor ($R_{BT},$ also equal to the characteristic impedance of the cable) may be placed between the AD827 output and the cable input, in order to damp any reflected signals caused by a mismatch between R_T and the cable's characteristic impedance. This will result in a flatter frequency response, although this requires that the op amp supply $\pm 2\ V$ to the output in order to achieve a $\pm 1\ V$ swing at resistor $R_T.$

A HIGH SPEED THREE OP AMP INSTRUMENTATION AMPLIFIER CIRCUIT

The instrumentation amplifier circuit shown in Figure 24 can provide a range of gains. Table II details performance.

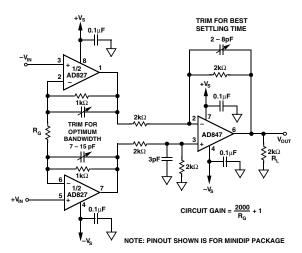


Figure 24. A High Bandwidth Three Op Amp Instrumentation Amplifier

Table II. Performance Specifications for the Three Op Amp Instrumentation Amplifier

Gain	R_G	Small Signal Bandwidth @ 1 V p-p Output
1	Open	16.1 MHz
2	2 k	14.7 MHz
10	226 Ω	4.9 MHz
100	20 Ω	660 kHz

REV. C -7-

AD827

A TWO-CHIP VOLTAGE-CONTROLLED AMPLIFIER (VCA) WITH EXPONENTIAL RESPONSE

Voltage-controlled amplifiers are often used as building blocks in automatic gain control systems. Figure 25 shows a two-chip VCA built using the AD827 and the AD539, a dual, current-output multiplier. As configured, the circuit has its two

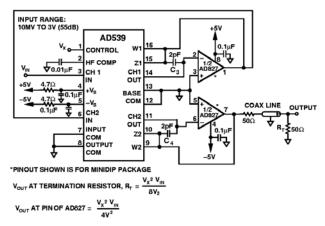


Figure 25. A Wide Range Voltage-Controlled Amplifier Circuit

multipliers connected in series. They could also be placed in parallel with an increase in bandwidth and a reduction in gain. The gain of the circuit is controlled by V_X , which can range from 0 to 3 V dc. Measurements show that this circuit easily supplies 2 V p-p into a $100~\Omega$ load while operating from ± 5 V supplies. The overall bandwidth of the circuit is approximately 7 MHz with 0.5 dB of peaking.

Each half of the AD827 serves as an I/V converter and converts the output current of one of the two multipliers in the AD539 into an output voltage. Each of the AD539's two multipliers contains two internal 6 k Ω feedback resistors; one is connected

between the CH1 output and Z1, the other between the CH1 output and W1. Likewise, in the CH2 multiplier, one of the feedback resistors is connected between CH2 and Z2 and the other is connected between CH2 and Z2. In Figure 25, Z1 and W1 are tied together, as are Z2 and W2, providing a 3 k Ω feedback resistor for the op amp. The 2 pF capacitors connected between the AD539's W1 and CH1 and W2 and CH2 pins are in parallel with the feedback resistors and thus reduce peaking in the VCA's frequency response. Increasing the values of C3 and C4 can further reduce the peaking at the expense of reduced bandwidth. The 1.25 mA full-scale output current of the AD539 and the 3 k Ω feedback resistor set the full-scale output voltage of each multiplier at 3.25 V p-p.

Current limiting in the AD827 (typically 30 mA) limits the output voltage in this application to about 3 V p-p across a 100 Ω load. Driving a 50 Ω reverse-terminated load divides this value by two, limiting the maximum signal delivered to a 50 Ω load to about 1.5 V p-p, which suffices for video signal levels. The dynamic range of this circuit is approximately 55 dB and is primarily limited by feedthrough at low input levels and by the maximum output voltage at high levels.

Guidelines for Grounding and Bypassing

When designing practical high frequency circuits using the AD827, some special precautions are in order. Both short interconnection leads and a large ground plane are needed whenever possible to provide low resistance, low inductance circuit paths. One should remember to minimize the effects of capacitive coupling between circuits. Furthermore, IC sockets should be avoided. Feedback resistors should be of a low enough value that the time constant formed with stray circuit capacitances at the amplifier summing junction will not limit circuit performance. As a rule of thumb, use feedback resistor values that are less than 5 k Ω . If a larger resistor value is necessary, a small (<10 pF) feedback capacitor in parallel with the feedback resistor may be used. The use of 0.1 μ F ceramic disc capacitors is recommended for bypassing the op amp's power supply leads.

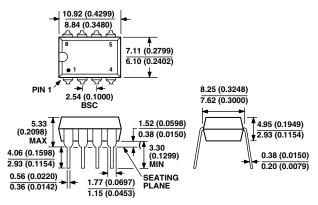
-8- REV. C

OUTLINE DIMENSIONS

8-Lead Plastic Dual-in-Line Package [PDIP]

(N-8)

Dimensions shown in millimeters and (inches)

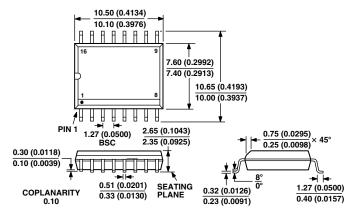


CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN

16-Lead Standard Small Outline Package [SOIC] Wide Body

(R-16)

Dimensions shown in millimeters and (inches)

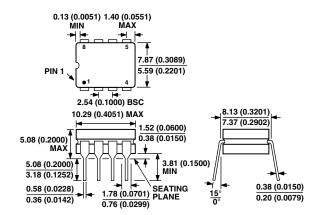


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COMPLIANT TO JEDEC STANDARDS MS-013AA

8-Lead Ceramic DIP-Glass Hermetic Seal Package [CERDIP] (Q-8)

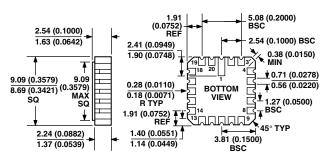
Dimensions shown in millimeters and (inches)



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20-Terminal Ceramic Leadless Chip Carrier [LCC] (E-20A)

Dimensions shown in millimeters and (inches)



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AD827

Revision History

Location	Page
8/02—Data Sheet changed from REV. B to REV. C.	
Updated Outline Dimensions	9